

Based on Form PTO-1449 (3/90)	ATTY. DOCKET NO. 930058-2004	SERIAL NO. 10/534,592
LIST OF REFERENCES CITED BY APPLICANT (Use several sheets if necessary)	APPLICANT David Anthony BARROW	
	FILING DATE May 11, 2005	GROUP Unassigned

U.S. PATENT DOCUMENTS

EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
/A.C./	BA	6,582,963 B1	06/24/03	Weigl et al	436	52	
	BB	2002/0090644 A1	07/11/02	Weigl et al	435	7.1	
	BC	2003/0124619 A1	07/03/03	Weigl et al	435	7.1	
	BD	2003/0211507 A1	11/13/03	Hatch et al.	435	6	
	BE	6,368,871 B1	04/09/02	Christel et al.	436	180	
	BF	6,391,541	05/21/02	Petersen et al.	435	5	
	BG	6,431,476 B1	08/13/02	Taylor et al.	241	1	
	BH	6,440,725 B1	08/27/02	Pourahmadi et al.	435	288	
	BI	2002/0055167 A1	05/09/02	Pourahmadi et al.	435	287.2	
	BJ	2004/0166031 A1	08/26/04	Taylor et al.	422	103	
	BK	6,818,185 B1	11/16/04	Petersen et al.	422	102	
	BL	2002/0045246 A1	04/18/02	McMillan et al.	435	306.1	

FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION	
							YES	NO
/A.C./	BM	WO 99/09042	02/25/99	WIPO				X
	BN	WO 02/12856 A1	02/14/02	WIPO				X
	BO	WO 01644332	09/07/01	WIPO				X
	BP	WO 02/23163 A1	03/21/02	WIPO				X
	BQ							
	BR							

OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, Etc.)

BS		
BT		
BU		
EXAMINER /Atif Chaudry/	DATE CONSIDERED 05/09/2008	

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/A.C./	CA	2001/0012612 A1	08/09/01	Petersen et al.	435	5	
	CB	2002/0039783 A1	04/04/02	McMillan et al.	435	287.2	
	CC	2002/0042125 A1	04/11/02	Petersen et al.	435	287.2	
	CD	2002/0019060 A1	02/14/02	Petersen et al.	435	514	
	CE	2002/0175079 A1	11/28/02	Christel et al.	204	601	
	CF	2002/0187547 A1	12/12/02	Taylor et al.	435	306.1	
	CG	2004/0200909 A1	10/14/04	McMillan et al.	241	1	
	CH	2005/0042137 A1	02/24/05	Petersen et al.	422	58	
	CI	2003/0145894 A1	08/07/03	Burns	137	833	
	CJ	2002/0058332 A1	05/16/02	Quake et al.	435	288.3	
	CK	6,524,456 B1	02/25/03	Ramsey et al.	204	450	
	CL	2004/0007463 A1	01/15/04	Ramsey et al.	204	450	
	CM	2002/0155032 A1	10/24/02	Liu et al.	422	100	
	CN	2002/0166592 A1	11/14/02	Liu et al.	137	825	
	CO	2002/0168780 A1	11/14/02	Liu et al.	436	180	
	CP	2003/0175165 A1	09/18/03	Liu	422	100	
	CQ	2002/0142618 A1	10/03/02	Parce et al.	438	751	

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							YES	NO
	CQ							

OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, Etc.)

	CR		
	CS		
	CT		
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/A.C./	AA	2002/0182747 A1	12/05/02	Beebe et al.	436	180	
	AB	2001/0055546 A1	12/27/01	Weigl et al.	422	100	
	AC	2003/0201022 A1	10/30/03	Kawai et al.	137	828	
	AD	5,716,852	02/10/98	Yager et al.	436	172	
	AE	5,932,100	08/03/99	Yager et al.	210	634	
	AF	5,948,684	09/07/99	Weigl et al.	436	52	
	AG	5,972,710	10/26/99	Weigl et al.	436	34	
	AH	6,171,865 B1	01/09/01	Weigl et al.	436	52	
	AI	6,262,907 B1	07/17/01	Lien et al.	365	49	
	AJ	6,454,945 B1	09/24/02	Weigl et al.	210	634	
	AK	6,541,213 B1	04/01/03	Weigl et al.	435	7.1	

FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLAS S	TRANSLATIO N	
							YES	NO
/A.C./	AL	WO 02/076878 A3	10/03/02	WIPO				X
	AM	WO 02/064253 A2	08/22/02	WIPO				X
	AN	WO 01/12327 A1	02/22/01	WIPO				X
	AO	WO 99/05512	02/04/99	WIPO				X
	AP	JP2002277478	09/25/02	JAPAN			X	

OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, Etc.)

/A.C./	AQ	John Oakey, et al., Laminar-Flow-Based Separations at the Microscale, Biotechnol. Prog. 2002, 18, 1439-1442
/A.C./	AR	Paul J.A. Kenis, et al., Fabrication Inside Microchannels Using Fluid Flow, Vol. 33, No. 12, 2000, Accounts of Chemical Research.
	AS	
	AT	
	AU	
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